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- Bidirectional Bus Transceivers in High-Density 20-Pin Packages
- True Logic
- 3-State Outputs
- Package Options Include Plastic Small-Outline (DW) Packages, Ceramic Chip Carriers (FK), and Standard Plastic (N) and Ceramic (J) 300-mil DIPs

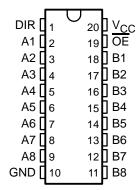
#### description

These octal bus transceivers are designed for asynchronous two-way communication between data buses. These devices transmit data from the A bus to the B bus or from the B bus to the A bus, depending on the level at the direction-control (DIR) input. The output-enable  $(\overline{OE})$  input can be used to disable the device so that the buses are effectively isolated.

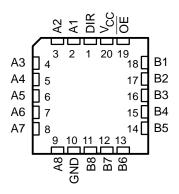
The -1 version of the SN74ALS645A is identical to the standard version, except that the recommended maximum  $I_{OL}$  is increased to 48 mA. There is no -1 version of the SN54ALS645A.

The SN54ALS645A and SN54AS645 are characterized for operation over the full military temperature range of -55°C to 125°C. The SN74ALS645A and SN74AS645 are characterized for operation from 0°C to 70°C.

SN54ALS645A, SN54AS645 . . . J PACKAGE SN74ALS645A, SN74AS645 . . . DW OR N PACKAGE (TOP VIEW)



SN54ALS645A, SN54AS645 . . . FK PACKAGE (TOP VIEW)



#### **FUNCTION TABLE**

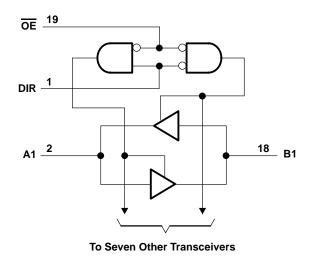
INP	UTS	ODED ATION
OE	DIR	OPERATION
L	L	B data to A bus
L	Н	A data to B bus
Н	X	Isolation

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#### logic symbol†

#### ŌĒ DIR 3 EN1 [BA] 3 EN2 [AB] 18 В1 $\triangleright$ 2 ▽ 17 B2 16 А3 **B3** 15 Α4 В4 14 Α5 **B5** 13 **B6** A6 12 Α7 **B7** 11 Α8 В8

### logic diagram (positive logic)



# absolute maximum ratings over operating free-air temperature range (unless otherwise noted)‡

	7 V
Input voltage, V <sub>I</sub> : All inputs	
I/O ports	5.5 V
Operating free-air temperature range, TA: SN54ALS	645A –55°C to 125°C
SN74ALS	345A 0°C to 70°C
Storage temperature range	65°C to 150°C

<sup>‡</sup> Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

#### recommended operating conditions

		SN	54ALS64	5A	SN7	4ALS64	I5A	UNIT
		MIN	NOM	MAX	MIN	NOM	MAX	UNII
VCC	Supply voltage	4.5	5	5.5	4.5	5	5.5	V
VIH	High-level input voltage	2			2			V
VIL	Low-level input voltage			0.7			0.8	V
loн	High-level output current			-12			-15	mA
1	Low lovel output ourrent			12			24	A
lOL	Low-level output current						48§	mA
TA	Operating free-air temperature	-55		125	0		70	°C

<sup>§</sup> Applies only to the -1 version and only if V<sub>CC</sub> is between 4.75 V and 5.25 V



<sup>†</sup> This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

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### electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CON	IDITIONS	SN54ALS645A		SN7	4ALS64	5A	UNIT	
	PARAMETER	TEST CON	TEST CONDITIONS		TYP <sup>†</sup>	MAX	MIN	TYP	MAX	UNII
٧ıK		V <sub>CC</sub> = 4.5 V,	I <sub>I</sub> = -18 mA			-1.5			-1.5	V
		$V_{CC} = 4.5 \text{ V to } 5.5 \text{ V},$	$I_{OH} = -0.4 \text{ mA}$	V <sub>CC</sub> -2	2		V <sub>CC</sub> -2	2		
\ <sub>\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\</sub>			$I_{OH} = -3 \text{ mA}$	2.4	3.2		2.4	3.2		V
∨он		V <sub>CC</sub> = 4.5 V	$I_{OH} = -12 \text{ mA}$	2						V
			$I_{OH} = -15 \text{ mA}$				2			
			I <sub>OL</sub> = 12 mA		0.25	0.4		0.25	0.4	
VOL		V <sub>CC</sub> = 4.5 V	I <sub>OL</sub> = 24 mA					0.35	0.5	V
			$I_{OL} = 48 \text{ mA}^{\ddagger}$					0.35	0.5	5
1.	Control inputs	V <sub>CC</sub> = 5.5 V	V <sub>I</sub> = 7 V			0.1			0.1	mA
11	A or B ports		V <sub>I</sub> = 5.5 V			0.1			0.1	ША
1	Control inputs	V 55V	V <sub>I</sub> = '2'.'Y' v			20			20	^
ΊΗ	A or B ports§	V <sub>CC</sub> = 5.5 V,	V  = 2.7 V			20			20	μΑ
1	Control inputs	V00 - 5 5 V	V• _0x1\x/ v			-0.1			-0.1	mA
ΊL	A or B ports§	V <sub>CC</sub> = 5.5 V,	VI =0:4 v			-0.1			-0.1	ША
IOI		$V_{CC} = 5.5 \text{ V},$	V <sub>O</sub> = 2.25 V	-20		-112	-30		-112	mA
			Outputs high		30	48		30	45	
ICC		V <sub>CC</sub> = 5.5 V	Outputs low		36	60		36	55	mA
			Outputs disabled		38	63		38	58	

# switching characteristics (see Figure 1)

PARAMETER	FROM (INPUT)	$\begin{array}{c} \text{V}_{\text{CC}} = 4.5 \text{ V to } 5.5 \text{ V,} \\ \text{C}_{\text{L}} = 50 \text{ pF,} \\ \text{R1} = 500 \ \Omega, \\ \text{R2} = 500 \ \Omega, \\ \text{T}_{\text{A}} = \text{MIN to MAX}^{\#} \end{array}$					
			SN54AL	S645A	SN74AL	S645A	
		MIN	MAX	MIN	MAX		
t <sub>PLH</sub>	A or B	ar B	1	19	3	10	ns
t <sub>PHL</sub>	AOLR	B or A	1	14	3	10	110
<sup>t</sup> PZH	<del></del>	<del>OE</del> A or B	2	30	5	20	ns
<sup>t</sup> PZL	OE		2	29	5	20	115
<sup>t</sup> PHZ	ŌĒ	A or B	2	14	2	10	ns
<sup>t</sup> PLZ	OE .	AUIB	2	30	4	15	115

<sup>#</sup> For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.



<sup>†</sup> All typical values are at  $V_{CC}$  = 5 V,  $T_A$  = 25°C. ‡ Applies only to the -1 version and only if  $V_{CC}$  is between 4.75 V and 5.25 V § For I/O ports, the parameters  $I_{IH}$  and  $I_{IL}$  include the off-state output current.

The output conditions have been chosen to produce a current that closely approximates one half of the true short-circuit output current, IOS.

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### absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

Supply voltage, V <sub>CC</sub>	7 V
Input voltage, V <sub>I</sub> : All inputs	7 V
I/O ports	
Operating free-air temperature range, T <sub>A</sub> : SN54AS645	55°C to 125°C
SN74AS645	0°C to 70°C
Storage temperature range	_65°C to 150°C

### recommended operating conditions

		SI	N54AS64	15	SI	174AS64	15	UNIT
		MIN	NOM	MAX	MIN	NOM	MAX	UNIT
Vcc	Supply voltage	4.5	5	5.5	4.5	5	5.5	V
$V_{IH}$	High-level input voltage	2			2			V
$V_{IL}$	Low-level input voltage			0.8			0.8	V
lOH	High-level output current			-12			-15	mA
lOL	Low-level output current			48			64	mA
TA	Operating free-air temperature	-55		125	0		70	°C

### electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

DADAMETED		TEOT 001	TEST CONDITIONS		SN54AS645			SN74AS645			
	PARAMETER	lesi coi	TEST CONDITIONS		TYP <sup>‡</sup>	MAX	MIN	TYP <sup>‡</sup>	MAX	UNIT	
٧ıĸ		V <sub>CC</sub> = 4.5 V,	I <sub>I</sub> = -18 mA			-1.2			-1.2	V	
		$V_{CC} = 4.5 \text{ V to } 5.5 \text{ V},$	I <sub>OH</sub> = −2 mA	V <sub>CC</sub> -2	2		V <sub>CC</sub> -2	2			
\/a			$I_{OH} = -3 \text{ mA}$	2.4	3.2		2.4	3.2		V	
VOH		V <sub>CC</sub> = 4.5 V	$I_{OH} = -12 \text{ mA}$	2.4						V	
			$I_{OH} = -15 \text{ mA}$				2.4				
\/0:		V <sub>CC</sub> = 4.5 V	I <sub>OL</sub> = 48 mA		0.3	0.55				V	
VOL		VCC = 4.5 V	I <sub>OL</sub> = 64 mA					0.35	0.55	l v	
١.	Control inputs	\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\	V <sub>I</sub> = 7 V			0.1			0.1	mA	
Ħ	A or B ports	V <sub>CC</sub> = 5.5 V	V <sub>I</sub> = 5.5 V			0.1			0.1	IIIA	
	Control inputs	V <sub>CC</sub> = 5.5 V,	V <sub>I</sub> =27.7′ v			20			20	μΑ	
ΊΗ	A or B ports§	VCC = 3.3 V,	V  = 2.7 V			70			70	μΑ	
	Control inputs	V <sub>CC</sub> = 5.5 V,	V₁ =°0'.\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\			-0.5			-0.5	mA	
II∟	A or B ports§	VCC = 5.5 V,	(C = 5.5 V, V = 0.4 V			-0.75			-0.75	ША	
IOI		$V_{CC} = 5.5 V,$	V <sub>O</sub> = 2.25 V	-50		-150	-50		-150	mA	
			Outputs high		62	97		62	97		
ICC		V <sub>CC</sub> = 5.5 V	Outputs low		95	149		95	149	mA	
			Outputs disabled		79	123		79	123		

<sup>‡</sup> All typical values are at  $V_{CC} = 5 \text{ V}$ ,  $T_A = 25^{\circ}\text{C}$ .



<sup>†</sup> Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

<sup>§</sup> For I/O ports, the parameters I<sub>IH</sub> and I<sub>IL</sub> include the off-state output current.

The output conditions have been chosen to produce a current that closely approximates one half of the true short-circuit output current, IOS.

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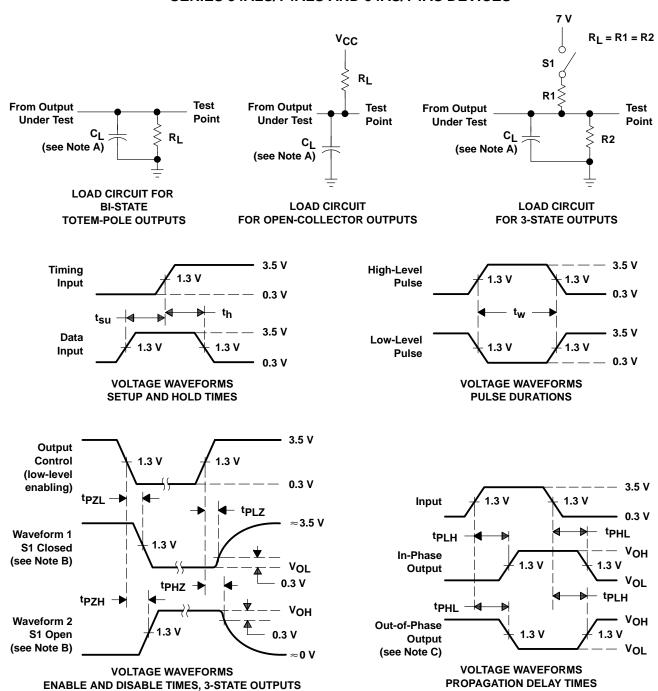
## switching characteristics (see Figure 1)

PARAMETER	R FROM (INPUT)	TO (OUTPUT)	V <sub>C</sub> C <sub>L</sub> R1 R2 T <sub>A</sub>	UNIT				
				SN54AS645		SN74AS645		
			MIN	MAX	MIN	MAX	]	
<sup>t</sup> PLH	A or B	D A	2	11	2	9.5	ns	
<sup>t</sup> PHL	AOID	B or A	2	10.5	2	9	115	
<sup>t</sup> PZH	ŌĒ	A D	2	12	2	11	20	
<sup>t</sup> PZL	OE	A or B	2	12	2	10	ns	
<sup>t</sup> PHZ	ŌĒ	A or B	2	8	2	7	ns	
t <sub>PLZ</sub>	OE .	AUID	2	13	2	12	115	

<sup>†</sup> For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

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#### PARAMETER MEASUREMENT INFORMATION SERIES 54ALS/74ALS AND 54AS/74AS DEVICES



NOTES: A. C<sub>I</sub> includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- C. When measuring propagation delay items of 3-state outputs, switch S1 is open.
- All input pulses have the following characteristics: PRR  $\leq$  1 MHz,  $t_{\Gamma} = t_{f} = 2$  ns, duty cycle = 50%.
- The outputs are measured one at a time with one transition per measurement.

Figure 1. Load Circuits and Voltage Waveforms



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